

## Notic of R ferenc s Cited

	Application/Control No. 09/441,958	Applicant(s)/Patent Under Reexamination SUMIYA ET AL.		
i	Examiner	 Art Unit		
	Thanh X Luu	2878	Page 1 of 1	

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Nam	Classi	Classification	
	A	US-5,072,105 A	12-1991	Osawa	250	206.1	
	В	US-5,567,976 A	10-1996	Dierschke et al	257	443	
	С	US-5,181,654 A	01-1993	Yoshimi et al	236	91C	
	D	US-4,315,690 A	02-1982	Trocellier et al	356	139.03	
	Е	US-					
	F	US-					
	G	US-					
	Н	US-					
	1	US-				,	
	J	US-					
	к	US-					
	L	US-					
	М	US-					

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification	
	N						
	0						
	Р						
	Q						
	R						
	s						
	Т						

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	*
	٧	•
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.